



6660-B Dobbin Road
Columbia, MD 21045 USA

Tel. 410.290.6652

Fax. 410.290.6654

<http://www.pctestlab.com>

February 02, 1999

Federal Communications Commission
Application Processing Branch
7435 Oakland Mills Road
Columbia, MD 21046
Attn: Joe Dichoso / Kwok Chan

In re: SAMSUNG Electronics Co., Ltd.
FCC ID: A3LSCH8000
Form 731 Confirmation No.: EA92294
Part 24 Certification / SAR
Single-Band PCS CDMA Phone
SAR Amendment

Dear Joe / Kwok:

Submitted herewith, on behalf of Samsung Electronics Co., Ltd., is an amendment per your e-mail request dated 01/29/99 requesting additional information for the subject application.

1. Attached is the SAR retest data taken with 0.25cm spacing at the worst-case condition. Please note that the attached SAR retest data is comparable to the previously submitted 1cm spacing test data.
2. Attached is clarification of the location of peak SAR for the hand configuration with respect to the phone and its antenna.
3. The extended battery was used during the original SAR measurements. Attached is EIRP test data using the standard battery, thus clarifying that there are no significant changes in the radiated performance which could effect the SAR.

We respectfully request that the grant be issued as soon as possible. If you have any questions regarding the above, please do not hesitate to contact us. Thank you.

Sincerely,

A handwritten signature in black ink, appearing to read "Al Cirwithian". The signature is fluid and cursive, with a large initial 'A' and 'C'.

Al Cirwithian
V.P. Engineering
PCTEST Lab

cc: Ben Kim, Engineering Manager
Samsung Electronics America

Attachment(s):

The logo for NVLAP (National Voluntary Laboratory Accreditation Program). It consists of the letters "NVLAP" in a bold, sans-serif font, with a registered trademark symbol (®) to the upper right. The letters are slightly stylized, with the 'V' and 'L' having a unique shape.